

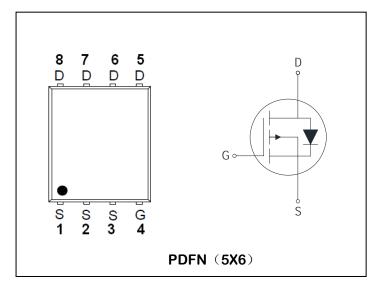
# P-Channel Logic Level Enhancement Mode Field Effect Transistor

#### **PRODUCT SUMMARY**

$V_{DSS}$	ID	$R_{DS(ON)}$ (m $\Omega$ )
-100V	-30A	38m $Ω$

#### Features:

- Low Gate Charge for Fast Switching Application
- Low Rds(ON) to Minimize Conductive Loss
- Reliable and Rugged
- 100% EAS Guaranteed



Absolute Maximum Ratings ( TA = 25°C unless otherwise specifed )

Symbol	Parameter	Ratings	Unit		
Common R	atings				
$V_{DSS}$	Drain-Source Voltage		-100	~	
$V_{GSS}$	Gate-Source Voltage		±20	V	
TJ	Maximum Junction Temperature		150	°C	
T <sub>STG</sub>	Storage Temperature Range		-55 to150	°C	
ls	Diode Continuous Forward Current	T <sub>C</sub> =25°C	-30	Α	
Mounted o	n Large Heat Sink				
lом	300µs Pulse Drain Current Tested (2)	T <sub>C</sub> =25°C, V <sub>GS</sub> =-10V	-120	Α	
ΙD	Continuous Drain Current (1)	T <sub>C</sub> =25°C, V <sub>GS</sub> =-10V	-30	А	
Pp	Maximum Power Dissipation	T <sub>C</sub> =25°C	73	W	

#### **Thermal Characteristics**

Symbol	Parameter	Ratings	Unit
RthJC	Thermal resistance junction-case max (1)	1.7	°C/W
RthJA	Thermal resistance junction-ambient max (1)	50	°C/W



# **ADM30P10Q**

# Electrical Characteristics (TA=25°C Unless Otherwise Noted)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
On/off Charac	teristics			-		
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =-250uA	-100			V
Ipss	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -80V, V <sub>GS</sub> =0V T <sub>J</sub> =25°C			-1	uA
VGS(th)	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250uA	-1.3	-1.9	-2.5	V
lgss	Gate Leakage Current	$V_{GS}$ = $\pm 20V$ , $V_{DS}$ = $0V$			±100	nA
	Drain-SourceOn-stateResistance(2)	V <sub>GS</sub> = -10V, I <sub>DS</sub> =-15A		32	38	mΩ
RDS(ON)		V <sub>GS</sub> = -4.5V, I <sub>DS</sub> =-10A	1	36	45	
Dynamic Chara	cteristics					
Ciss	Input Capacitance	V <sub>GS</sub> =0V,		6510		
Coss	Output Capacitance	V <sub>DS</sub> = -30V,		228		pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz		175		
Switching Char	acteristics					
td(ON)	Turn-on Delay Time(1)	V <sub>DD</sub> =-50V,		22		
<b>t</b> r	Turn-on Rise Time(1)	I <sub>D</sub> = -1A, V <sub>GS</sub> = -10V,		26		no
td(OFF)	Turn-off Delay Time(1)	R <sub>GEN</sub> =6.8 Ω		74		ns
tf	Turn-off Fall Time(1)			66		
Qg	Total Gate Charge(1)	V <sub>DS</sub> =-50V, V <sub>GS</sub> = -10V,		69		
Qgs	Gate-Source Charge(1)	I <sub>DS</sub> =-10A		14		nC
Qgd	Gate-Drain Charge(1)			19		
Avalanche Ch	aracteristics					
		V <sub>DD</sub> =25V,L=0.5mH ,V <sub>GS</sub> =10				
EAS	Single Pulse Avalanche Energy (3)	$V,R_g=25\Omega$ , $I_{AS}=-35A$	306			mJ
		T <sub>J</sub> =25°C				
Diode Charact	eristics					
VsD	Diode Forward Voltage(2)	$I_{SD}$ =-30A, $V_{GS}$ = 0V $T_{J}$ =25°C	-1	-0.9	-1.3	V
trr	Reverse Recovery Time	lo==104 dlo=/dt=1004/co	1	52		ns
<b>q</b> rr	Reverse Recovery Charge	I <sub>SD</sub> =10A, dI <sub>SD</sub> /dt=100A/μs		128		nC

#### NOTES:

<sup>1.</sup> Surface Mounted on FR4 Board,  $t \le 10$  sec.

<sup>2.</sup>The data tested by pulsed , pulse width  $\,\leq\,\,300\text{us}$  , duty cycle  $\,\leq\,\,2\%$ 

<sup>3.</sup>The Min. value is 100% EAS tested guarantee.



### **Typical Performance Characteristics**

Figure 1: On-Region Characteristics

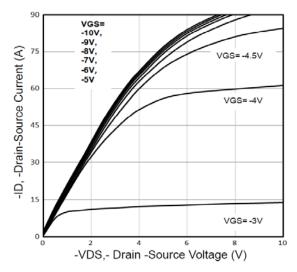


Figure 3: -VGS(TH) Gate -Source VoltageVs.Tj

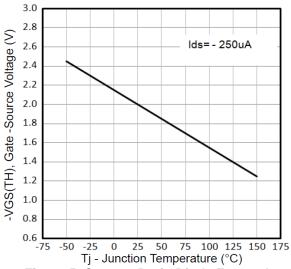
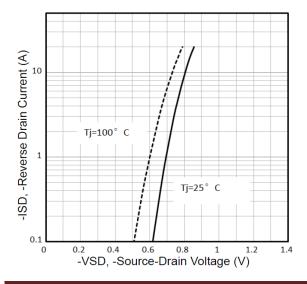


Figure 5: Source- Drain Diode Forward



**Figure 2: Transfer Characteristics** 

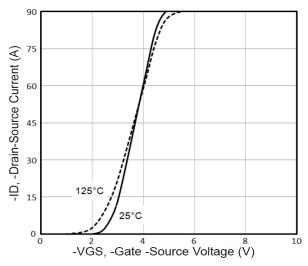


Figure 4: Normalized On-Resistance Vs. Tj

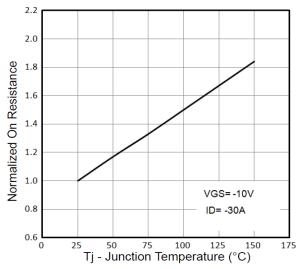


Figure 6: Gate Charge Characteristics

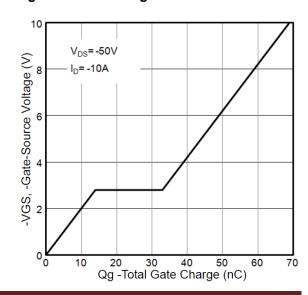




Figure 7: Capacitance vs Vds

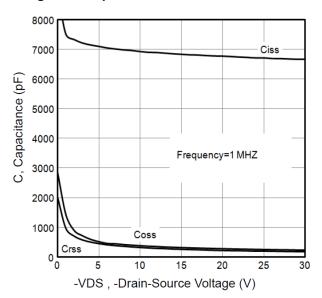


Figure 8: Safe Operation Area

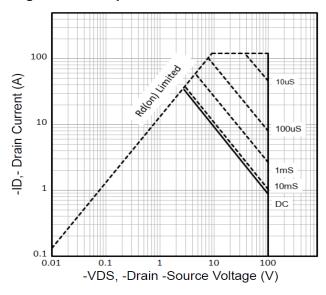
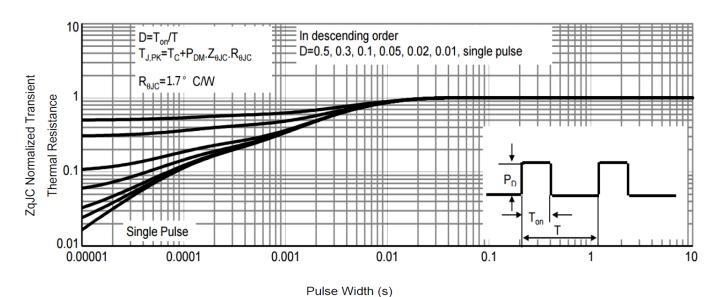


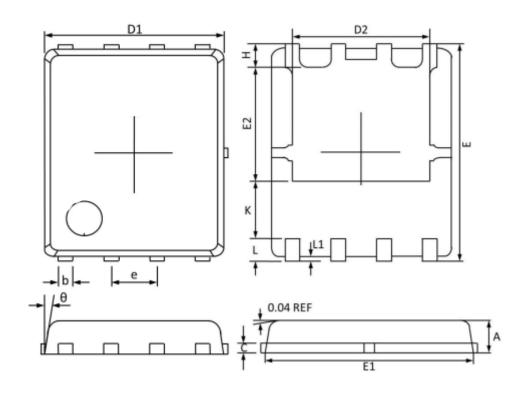
Figure 9: Normalized Maximum Transient Thermal Impedance



4 / 6 www.advsemi.com Feb,2014 -Rev.1.01



# PACKAGE MECHANICAL DATA PDFN (5X6) Package Dimension



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	0.800	1.100	0.031	0.043	
b	0.330	0.510	0.013	0.020	
С	0.200	0.300	0.008	0.012	
D1	4.800	5.100	0.189	0.201	
D2	3.610	4.100	0.142	0.161	
Е	5.900	6.200	0.232	0.244	
E1	5.700	5.900	0.224	0.232	
E2	3.350	3.780	0.132	0.149	
Н	0.410	0.700	0.016	0.028	
K	1.100	1.500	0.043	0.059	
е	1.270 TYP.		0.050 TYP.		
L	0.510	0.710	0.020	0.028	
L1	0.060	0.200	0.002	0.008	
θ	0°	12°	0°	12°	



## **ADM30P10Q**

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6 / 6 www.advsemi.com Feb,2014 -Rev.1.01